Search Notes			
	MARKAN DIKERA		
1 1 0 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/815,516	CAIN ET AL.	
Examiner	Art Unit	
Alan S. Chen	2182	

SEARCHED			
Class	Subclass	Date	Examiner
710	15	10/10/2006	ASC
	16		1
	17		
	18		
	19		
	62		
			-
			٠

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
•				
Sce see	urch, printauk	9/14/07	ASC	

(INCLUDING SEARCH STRATEGY) DATE EXME		
(EAST) USPAT; USPGPUB; EPO; JPO; IBM_TDB; DERWENT	10/10/2006	ASC
whited alass search updated. EAST	4/31/67	ASC
	`	,